

# Search Notes



Application No.

10/602,383

Examiner

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Applicant(s)

SANCHEZ PINA ET AL.

Art Unit

2857

## SEARCHED

Class	Subclass	Date	Examiner
702	30,50,45, 47,24,25, 27,31,32, 52,55	10-29-04	W
702	114,130, 138,140	10-29-04	W
702	136,183, 100	10-29-04	W
73	146,125, 126,134	10-30-04	W
73	125,157, 159,35-02	10-30-04	W
73	3504,37, 53-01,53-04	10-30-04	W
73	53-05,54-01, 54-02,290R	10-30-04	W
73	54-05,54-07, 54-09,54-11	10-30-04	W
73	54-13,54-14, 61,73,152-18	10-30-04	W
73	152-21,152-22, 152-29,861-02	10-30-04	W
73	861-03,861-08, 861-12,861-14	10-30-04	W
73	861-15,861-35, 861-35,861-35	10-30-04	W
73	304C, 195,118.2	10-30-04	W
340	612,618, 603,606,611	10-31-04	W

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
700	266,281, 282	10-31-04	W
701	99,102, 104	10-31-04	W
324	663,664,667, 665,698	10-31-04	W

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Plus search	8-18-04	W
East text search	10-30-04	W
IEEE database search	10-30-04	W